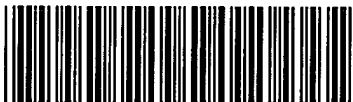


**Search Notes**

Application/Control No.

10/790,931

Examiner

Deborah Yee

Applicant(s)/Patent under  
Reexamination

TAKAYAMA ET AL.

Art Unit

1742

**SEARCHED**

Class	Subclass	Date	Examiner
148	333,572 573, 575 906	12/4/2005	DY
384	+		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventorship search west	12/4/2005	DY